Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/636,118	RICART ET AL.	+
Examiner	Art Unit	
Lewis A. Bullock, Jr.	2195	

SEARCHED			
Class	Subclass	Date	Examiner
718	1,100-108	8/31/2007	LAB
712	1-300	8/31/2007	LAB
708	1-854	8/31/2007	LAB
UPDA	ていか	10/24/07	300

INTERFERENCE SEARCHED		
Subclass	Date	Examiner
102,105	10/29/57	ps
442	10/2457	JEB
16,28,30	10/24/07	Jess
	Subclass 102,105 442	Subclass Date 102,105 147407 442 1012407

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	DATE	EXMR
EAST ACM IEEE GOOGLE SCHOLAR	8/31/2007	LAB
UPDATON	1929/07	gen
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